


<b>Search Notes</b>  	<b>Application/Control No.</b>  10510089	<b>Applicant(s)/Patent Under Reexamination</b>  EBIHARA ET AL.
	<b>Examiner</b>  MIZRAHI, DIANE D	<b>Art Unit</b>  2165

SEARCHED			
Class	Subclass	Date	Examiner
707	1-10, 100-104.1, 200-205	3-27-07	dm
713	164		
705	51,59		

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE Jeff Gaffin	6-14-07	dm
Keyword and concept search (see attached classification and text search report)INVENTOR SEARCH; DOUBLE PATENTING; USPTO; USPG; EPO; JPO; DERWENT; IBM TECH; INTERNET; NPL; PERSONAL DIGESTS.	12-27-07	dm

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner